Form PTO 1449		U.S. DEPARTMENT OF COMMERCE		ATTY DOCKET NO.		SERIAL NO.	
(Modified) PATENT AND TRADEMARK OFFICE			294136US0X PCT		10/589,247		
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AF	PPLICANT	Tatsuya NAKAI, et al.			
				FILING DATE		GROUP	
				August 14, 2006		1616	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS		SUB FILING DATE CLASS IF APPROPRIATE	
	AA	2006/0127464 A1	06/15/2006	Takaya SUGAWARA, et al.			
	AB	2005/0255149 A1	11/17/2005	Takashi NARUI, et al.			
	AC	2003/0175331 A1	09/18/2003	Yasuhiko SASAKI, et al.			
	AD	2010/0047325 A1	02/25/2010	Yasuhiko SASAKI, et al.	_		
	AE	2010/0055160 A1	03/04/2010	Yasuhiko SASAKI, et al.			
	AF	2004/0059110 A1	03/25/2004	Takashi NAKANO, et al.			
	AG	6,721,595 B1	04/13/2004	Yoshihiro TOKUDOME, et al.			
	АН						
	AI						
		<u> </u>	FO	REIGN PATENT DOCUMENTS			
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION	
	AJ	2002-520272	07/09/2002	JAPAN (with corr. WO 00/02541 A1)		YES	S NO X
	AK	WO 00/02541 A1	01/20/2000	WIPO (with English Abstract)			X
	AL 2004-75537 03/11/2004 JAPAN (corr. to US 2006/0127464 A1)				X		
	AM	2004-51487	02/19/2004	JAPAN (corr. to US 2005/0255149 A1)			Х
	AN	2003-201217	07/18/2003	Computer-Generated English translation	APAN (with English Abstract and Unedited omputer-Generated English translation)		
	AO	2003-155238	05/27/2003	Computer-Generated English translation			
	AP	2002-338462	11/27/2002	JAPAN (corr. to US 2003/0175331 A1, US 2010/0047325 A1 and US 2010/005			×
	AQ	2002-332228	11/22/2002	JAPAN (with English Abstract and Unec Computer-Generated English translation		X	
	AR	2002-226457	08/14/2002	JAPAN (corr. to US 2004/0059110 A1)			X
	AS	WO 01/26688 A1	04/19/2001	WIPO (with English Abstract, corr. to US 6,721,595 B1)			×
	АТ	WO 00/64434 A1	11/02/2000	WIPO (with English Abstract and corr. EP 1 174 132 A1)			×
	AU	1 174 132 A1	01/23/2002	EUROPE			
	AV	WO 00/01384 A1	01/13/2000	WIPO (with English Abstract)			Х
		OTHER R	EFERENCES	(Including Author, Title, Date, Pertinent	Pages, e	etc.)	
Office Action issued August 23, 2011, in Japanese Patent Application no. 2006-511711 with English translation.							
	AW						
					····		
	AX						<u> </u>
	AY						
	AZ		· · · · · · · · · · · · · · · · · · ·	☐ Additional References sheet(s) attached			
Examiner					Date Considered		
*Examiner: I	nitial if	reference is considered	i, whether or no	ot citation is in conformance with MPEP 60			citation if not in
conformance	and no	ot considered. Include	copy of this forr	n with next communication to applicant.			